

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10591876	MIYASHITA, TAKASHIGE
	Examiner	Art Unit
	Hai Phan	2614

SEARCHED

Class	Subclass	Date	Examiner
381	94.1, 94.2, 94.3, 98, 99, 100	06/14/10	HP
327	554, 561	06/14/10	HP
455	307	06/14/10	HP

SEARCH NOTES

Search Notes	Date	Examiner
EAST Search	06/14/10	HP
Inventor Search	06/14/10	HP

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

/Hai Phan/
Examiner.Art Unit 2614